Search Notes						

Application/Control No.	Applicant(s)/Patent under Reexamination
10/823,656	KANG, EUN-JIN
Examiner	Art Unit
James L. Habermehl	2651

SEARCHED				
Class	Subclass	Date	Examiner	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
*				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (USPAT, PGPub, JPO, EPO, IBM TDB)—see search history printout	11/20/2005	JLH
inventor search	11/20/2005	JLH
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